


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/849,322	KLEIN, PAUL F.	
	Examiner	Art Unit	
	Djenane M. Bayard	2141	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
709	232				709	202	224	233	
INTERNATIONAL CLASSIFICATION									
G	0	6	F	15/16					
				/					
				/					
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<i>Djenane Bayard</i> 9/15/08 (Assistant Examiner) (Date)		<i>RUPAL DHARIA</i> 9/18/08 SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date)		Total Claims Allowed: 30 O.G. Print Claim(s) 1 O.G. Print Fig. 1	
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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